

UNISONIC TECHNOLOGIES CO., LTD

UTT120N04M

Preliminary

Power MOSFET

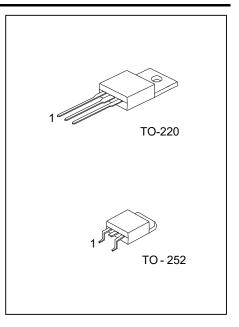
120A, 40V N-CHANNEL POWER MOSFET

■ DESCRIPTION

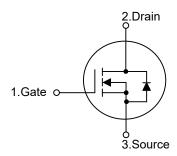
The UTC **UTT120N04M** is an N-channel enhancement mode Power FET, it uses UTC's advanced technology to provide customers a minimum on-state resistance and high switching speed.

■ FEATURES

- * $R_{DS(ON)} \le 3.9 \text{ m}\Omega$ @ V_{GS} =10V, I_{D} =60A $R_{DS(ON)} \le 7.8 \text{ m}\Omega$ @ V_{GS} =4.5V, I_{D} =60A
- * High switching speed
- * Improved dv/dt capability



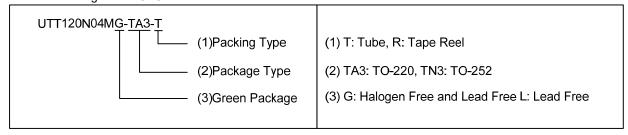
■ SYMBOL



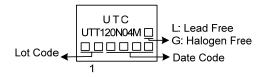
ORDERING INFORMATION

Ordering Number		Daalaana	Pin Assignment			Da alsia a	
Lead Free	Halogen Free	Package	1	2	3	Packing	
UTT120N04ML-TA3-T	UTT120N04MG-TA3-T	TO-220	G	D	S	Tube	
UTT120N04ML-TN3-R	UTT120N04MG-TN3-R	TO-252	G	D	S	Tape Reel	

Note: Pin Assignment: G: Gate D: Drain S: Source



■ MARKING



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■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V _{DSS}	40	V
Gate-Source Voltage		V _{GSS}	±20	V
Drain Current	Continuous	I _D	120	Α
	Pulsed (Note 2)	I _{DM}	240	Α
Avalanche Energy	lanche Energy Single Pulsed (Note 3)		186	mJ
Peak Diode Recovery dv/dt (Note 4)		dv/dt	1.1	V/ns
Power Dissipation	TO-220	Б	200	W
	TO-252	P _D	70	W
Junction Temperature		TJ	+150	°C
Storage Temperature Range		T _{STG}	-55 ~ +150	°C

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature.
- 3. L=0.1mH, I_{AS}=61A, V_{DD} =25V, R_{G} =25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 4. I_{SD} \leq 30A, di/dt \leq 200A/ μ s, V_{DD} \leq BV_{DSS}, Starting T_J = 25°C

■ THERMAL DATA

PARAMETER		SYMBOL	RATING	UNIT	
Junction to Ambient	TO-220	0	62.5	°C/W	
	TO-252	θја	110	°C/W	
Junction to Case	TO-220	0	0.62	°C/W	
	TO-252	θις	1.78 (Note)	°C/W	

Note: Device mounted on FR-4 substrate P_C board, 2oz copper, with 1inch square copper plate.

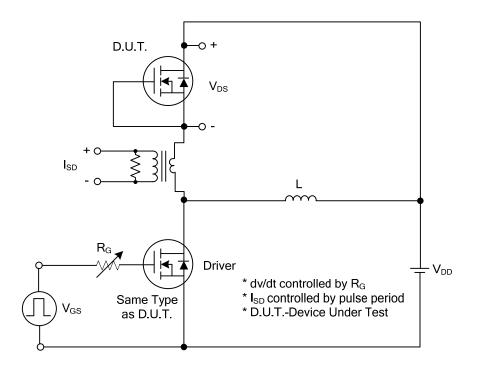
■ ELECTRICAL CHARACTERISTICS (TJ=25°C, unless otherwise specified)

PARAMETER		SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT		
OFF CHARACTERISTICS									
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V	40			V		
Drain-Source Leakage Current		I _{DSS}	V _{DS} =40V			1	μΑ		
Gate-Source Leakage Current	Forward		V _{GS} =+20V, V _{DS} =0V			+100	nA		
	Reverse	Igss	V _{GS} =-20V, V _{DS} =0V			-100	nA		
ON CHARACTERISTICS									
Gate Threshold Voltage		$V_{GS(TH)}$	I _D =250μA, V _{DS} =V _{GS} 1.0			3.0	V		
Static Drain-Source On-State Resistance		R _{DS(ON)}	V _{GS} =10V, I _D =60A			3.9	mΩ		
			V _{GS} =4.5V, I _D =60A			7.8	mΩ		
DYNAMIC PARAMETERS									
Input Capacitance		Ciss			5578		рF		
Output Capacitance		Coss	V _{DS} =25V, V _{GS} =0V, f=1MHz		800		рF		
Reverse Transfer Capacitance		Crss			700		рF		
SWITCHING PARAMETERS									
Total Gate Charge		Q_{G}	-\/22\/ \/=10\/ 120A		145		nC		
Gate to Source Charge		Q _{GS}	V _{DD} =32V, V _{GS} =10V, I _D =120A, (Note 1, 2)		50		nC		
Gate to Drain Charge		Q_GD	(Note 1, 2)		46		nC		
Turn-ON Delay Time		t _{D(ON)}			15		ns		
Rise Time		t _R	V_{DD} =20V, I_{D} =120A, R_{G} =3 Ω ,		20		ns		
Turn-OFF Delay Time		t _{D(OFF)}	V _{GS} =10V (Note 1, 2)		48		ns		
Fall-Time		t⊧			22		ns		
SOURCE- DRAIN DIODE RATINGS AND CHARACTERISTICS									
Maximum Body-Diode Continuous Current		Is				120	Α		
Maximum Body-Diode Pulsed Current		lsм				240	Α		
Drain-Source Diode Forward Voltage		VsD	Is=120A			1.4	V		
Reverse Recovery Time		t _{rr}	Is =30A, V _{GS} =0V		76		nS		
Reverse Recovery Charge (Note 1)		Qrr	dI _F /dt=100A/μs		140		nC		

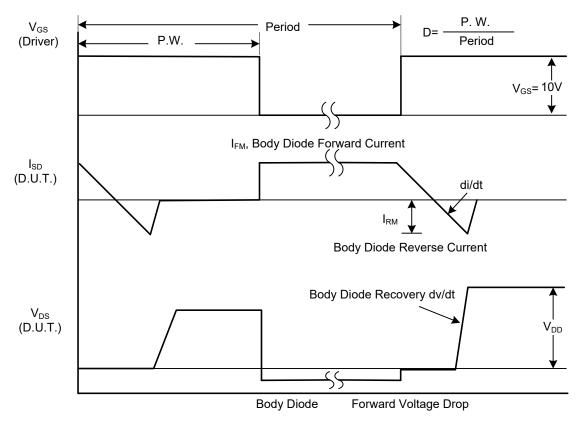
Notes: 1. Pulse Test : Pulse width ≤ 300µs, Duty cycle ≤ 2%.

^{2.} Essentially independent of operating ambient temperature.

■ TEST CIRCUITS AND WAVEFORMS

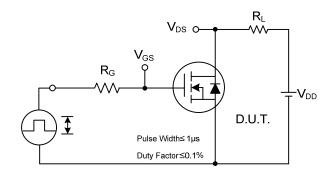


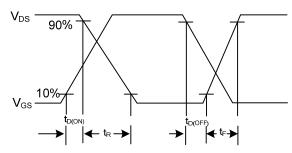
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

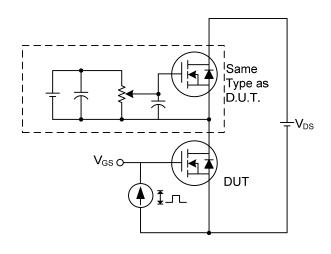
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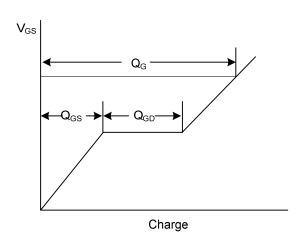




Switching Test Circuit

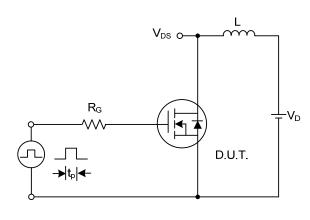
Switching Waveforms

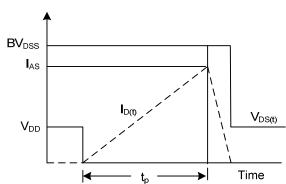




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

Unclamped Inductive Switching Waveforms

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